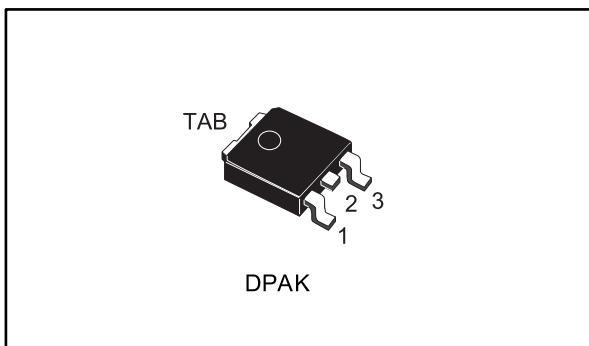
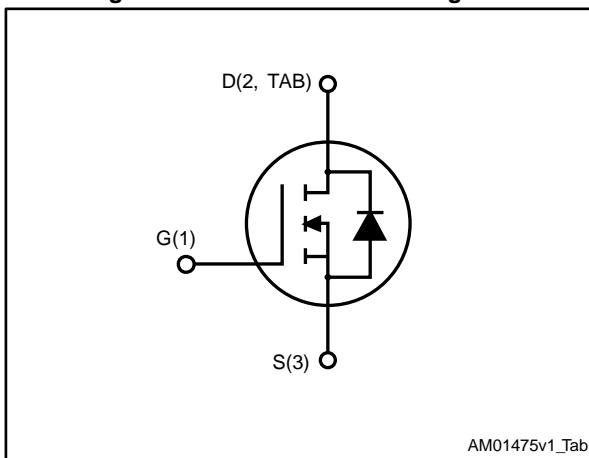


## Automotive-grade N-channel 60 V, 19 mΩ typ., 24 A STripFET™ F6 Power MOSFET in a DPAK package

Datasheet - production data



**Figure 1: Internal schematic diagram**



### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STD30N6LF6AG	60 V	25 mΩ	24 A	40 W

- Designed for automotive applications and AEC-Q101 qualified
- Very low on-resistance
- Very low gate charge
- High avalanche ruggedness
- Low gate drive power loss

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using the STripFET™ F6 technology with a new trench gate structure. The resulting Power MOSFET exhibits very low R<sub>DS(on)</sub> in all packages.

**Table 1: Device summary**

Order code	Marking	Package	Packing
STD30N6LF6AG	30N6LF6	DPAK	Tape and Reel

**Contents**

<b>1</b>	<b>Electrical ratings .....</b>	<b>3</b>
<b>2</b>	<b>Electrical characteristics .....</b>	<b>4</b>
2.1	Electrical characteristics (curves).....	6
<b>3</b>	<b>Test circuits .....</b>	<b>8</b>
<b>4</b>	<b>Package information .....</b>	<b>9</b>
4.1	DPAK (TO-252) type A package information.....	9
4.2	DPAK (TO-252) packing information.....	12
<b>5</b>	<b>Revision history .....</b>	<b>14</b>

# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	60	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D$	Drain current (continuous) at $T_{case} = 25^\circ\text{C}$	24	A
	Drain current (continuous) at $T_{case} = 100^\circ\text{C}$	17	
$I_{DM}^{(1)}$	Drain current (pulsed)	96	A
$P_{TOT}$	Total dissipation at $T_{case} = 25^\circ\text{C}$	40	W
$E_{AS}^{(2)}$	Single pulse avalanche energy	130	mJ
$T_{stg}$	Storage temperature	-55 to 175	$^\circ\text{C}$
$T_j$	Operating junction temperature		

**Notes:**

(1) Pulse width is limited by safe operating area.

(2) starting  $T_j = 25^\circ\text{C}$ ,  $I_D = 24\text{ A}$ ,  $V_{DD} = 43.5\text{ V}$ .**Table 3: Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	3.75	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb	35	

**Notes:**(1) When mounted on a 1-inch<sup>2</sup> FR-4 board, 2 oz Cu.

## 2 Electrical characteristics

( $T_{\text{case}} = 25^\circ\text{C}$  unless otherwise specified)

**Table 4: Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	60			V
$I_{\text{DSS}}$	Zero gate voltage drain current	$V_{\text{GS}} = 0 \text{ V}$ , $V_{\text{DS}} = 60 \text{ V}$			1	$\mu\text{A}$
		$V_{\text{GS}} = 0 \text{ V}$ , $V_{\text{DS}} = 60 \text{ V}$ , $T_{\text{case}} = 125^\circ\text{C}$			100	
$I_{\text{GSS}}$	Gate-body leakage current	$V_{\text{DS}} = 0 \text{ V}$ , $V_{\text{GS}} = \pm 20 \text{ V}$			$\pm 100$	nA
$V_{\text{GS}(\text{th})}$	Gate threshold voltage	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250 \mu\text{A}$	1		2.5	V
$R_{\text{DS}(\text{on})}$	Static drain-source on-resistance	$V_{\text{GS}} = 10 \text{ V}$ , $I_D = 12 \text{ A}$		19	25	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5 \text{ V}$ , $I_D = 12 \text{ A}$		24	30	

**Table 5: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{\text{iss}}$	Input capacitance	$V_{\text{DS}} = 25 \text{ V}$ , $f = 1 \text{ MHz}$ , $V_{\text{GS}} = 0 \text{ V}$	-	1320	-	pF
$C_{\text{oss}}$	Output capacitance		-	88.5	-	
$C_{\text{rss}}$	Reverse transfer capacitance		-	58	-	
$Q_g$	Total gate charge	$V_{\text{DD}} = 30 \text{ V}$ , $I_D = 24 \text{ A}$ , $V_{\text{GS}} = 10 \text{ V}$ (see <a href="#">Figure 14: "Gate charge test circuit"</a> )	-	26	-	nC
$Q_{\text{gs}}$	Gate-source charge		-	6	-	
$Q_{\text{gd}}$	Gate-drain charge		-	3.3	-	

**Table 6: Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{\text{d}(\text{on})}$	Turn-on delay time	$V_{\text{DD}} = 30 \text{ V}$ , $I_D = 12 \text{ A}$ , $R_G = 4.7 \Omega$ , $V_{\text{GS}} = 10 \text{ V}$ (see <a href="#">Figure 13: "Switching times test circuit for resistive load"</a> and <a href="#">Figure 18: "Switching time waveform"</a> )	-	10	-	ns
$t_r$	Rise time		-	19	-	
$t_{\text{d}(\text{off})}$	Turn-off delay time		-	56	-	
$t_f$	Fall time		-	7	-	

Table 7: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		24	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		96	A
$V_{SD}^{(2)}$	Forward on voltage	$V_{GS} = 0 \text{ V}$ , $I_{SD} = 24 \text{ A}$	-		1.3	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 24 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 48 \text{ V}$ , $T_J = 150 \text{ }^\circ\text{C}$ (see <i>Figure 15: "Test circuit for inductive load switching and diode recovery times"</i> )	-	22.4		ns
$Q_{rr}$	Reverse recovery charge		-	22.2		nC
$I_{RRM}$	Reverse recovery current		-	2		A

**Notes:**

(1) Current is limited by package.

(2) Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1

## Electrical characteristics (curves)

Figure 2: Safe operating area

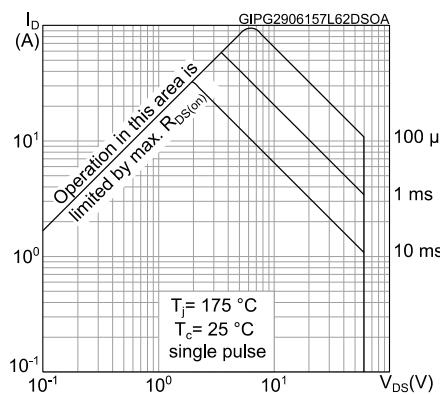


Figure 3: Thermal impedance

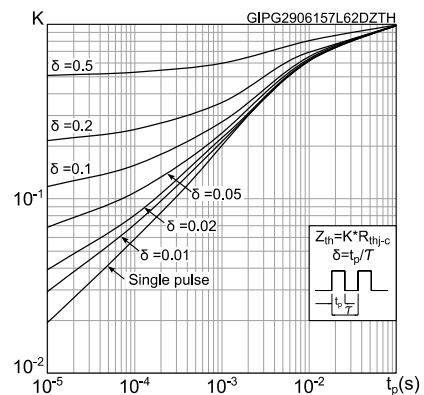


Figure 4: Output characteristics

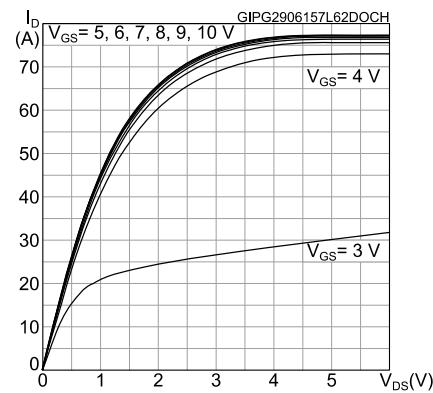


Figure 5: Transfer characteristics

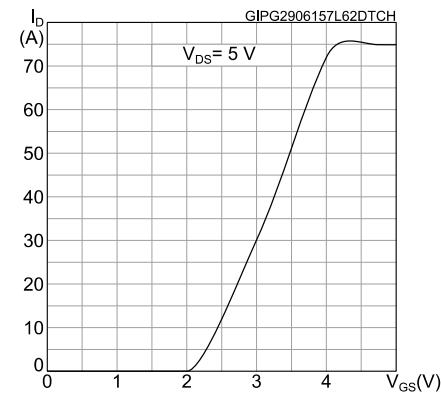


Figure 6: Gate charge vs gate-source voltage

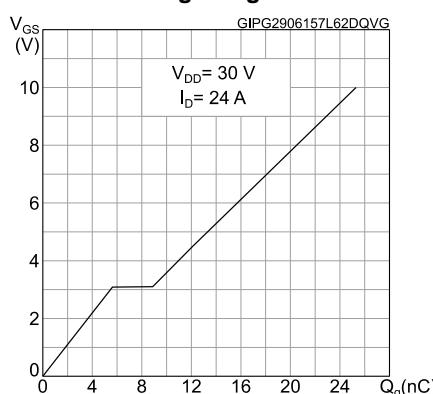
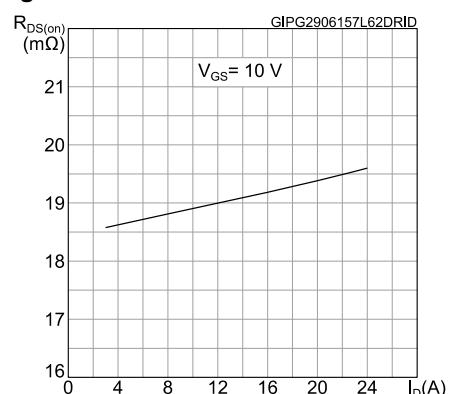
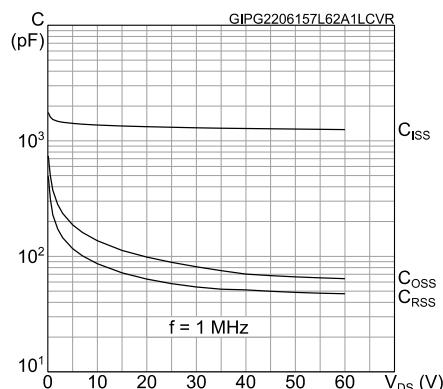
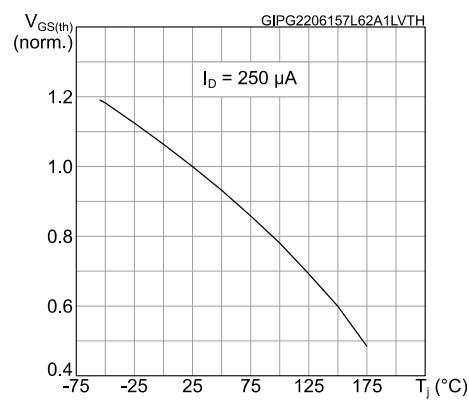
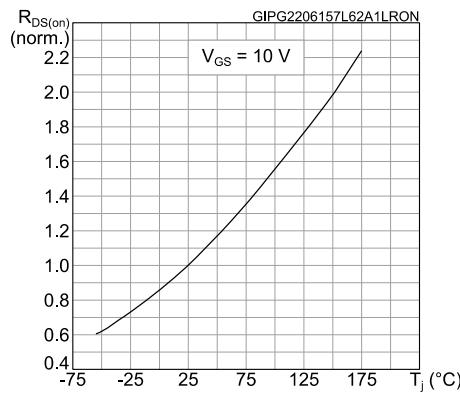
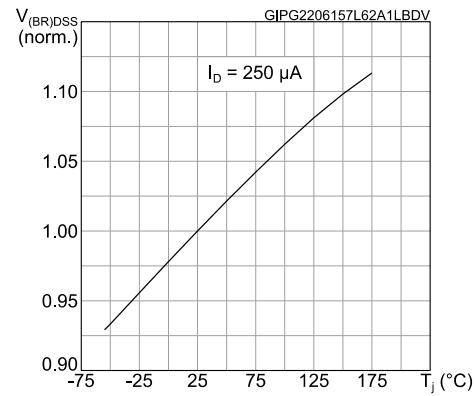
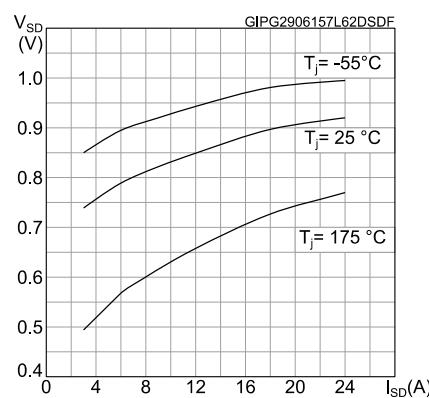


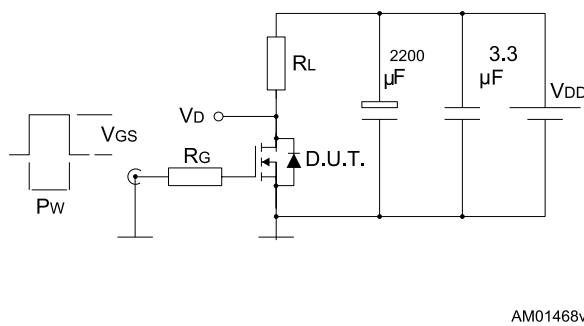
Figure 7: Static drain-source on-resistance



**Figure 8: Capacitance variations****Figure 9: Normalized gate threshold voltage vs temperature****Figure 10: Normalized on-resistance vs temperature****Figure 11: Normalized V(BR)DSS vs temperature****Figure 12: Source-drain diode forward characteristics**

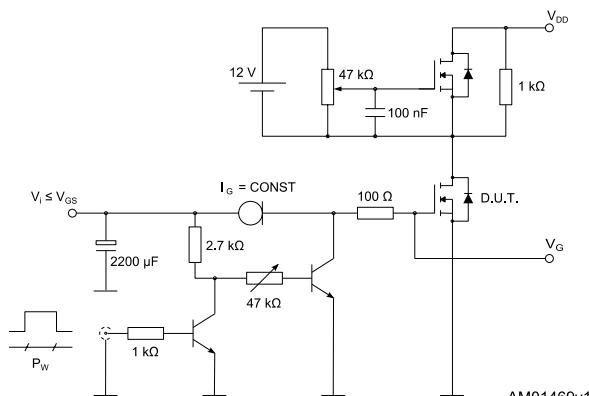
### 3 Test circuits

**Figure 13: Switching times test circuit for resistive load**



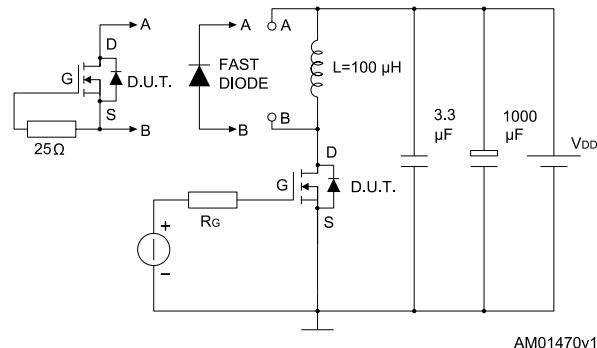
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**Figure 14: Gate charge test circuit**



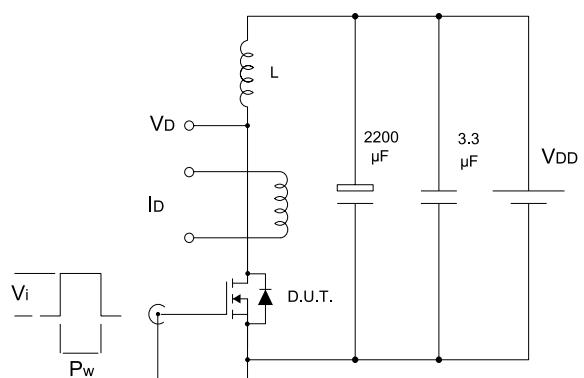
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**Figure 15: Test circuit for inductive load switching and diode recovery times**



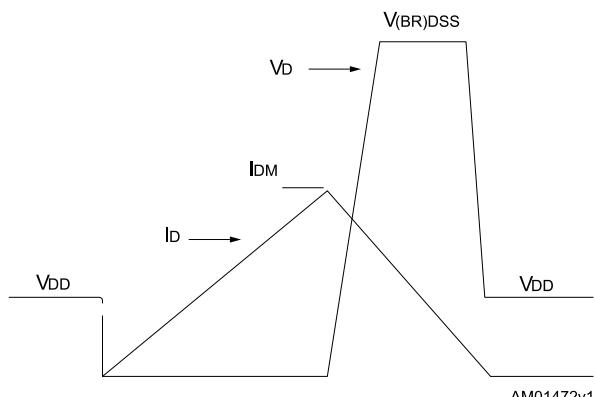
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**Figure 16: Unclamped inductive load test circuit**



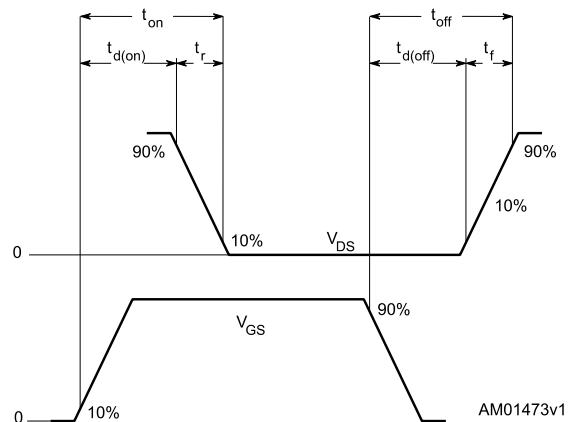
AM01471v1

**Figure 17: Unclamped inductive waveform**



AM01472v1

**Figure 18: Switching time waveform**



AM01473v1

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

### 4.1 DPAK (TO-252) type A package information

Figure 19: DPAK (TO-252) type A package outline

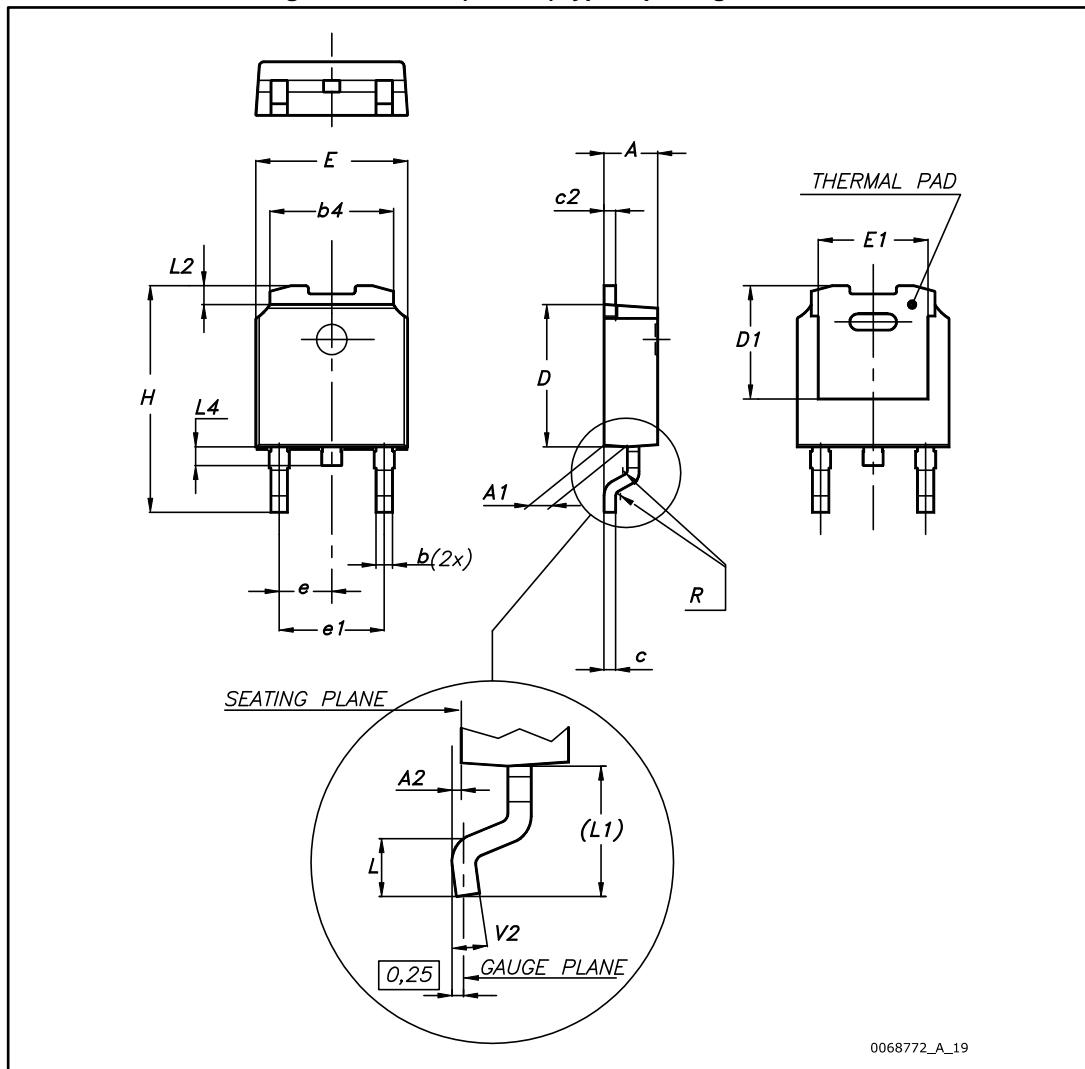
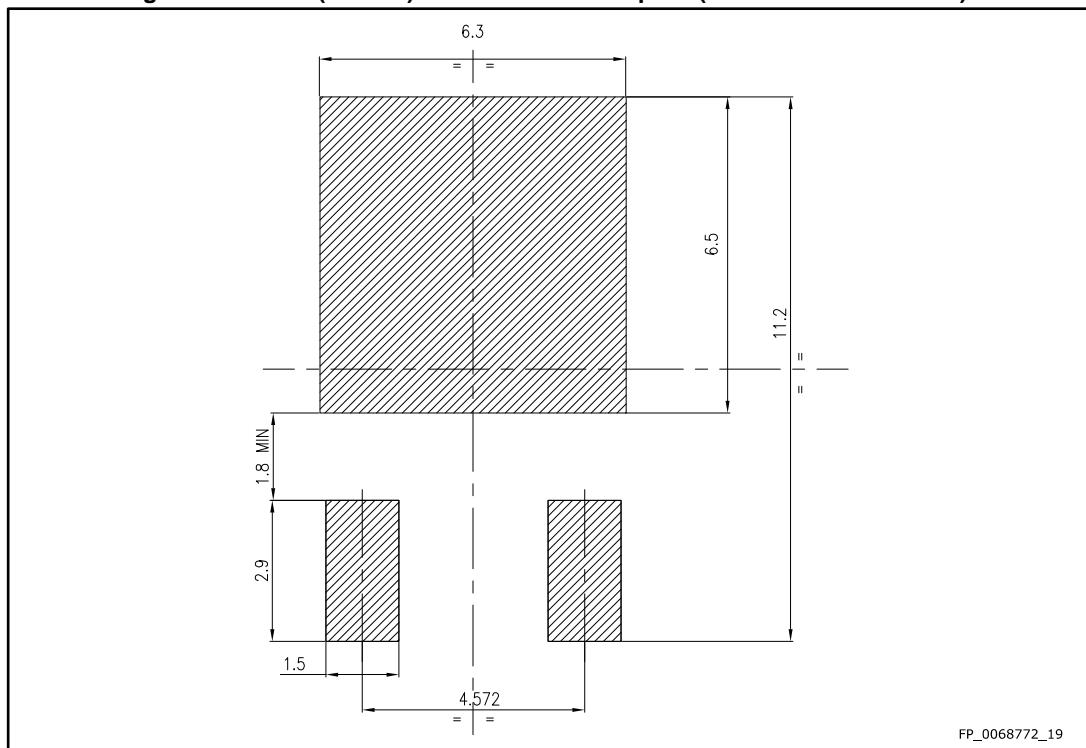


Table 8: DPAK (TO-252) type A mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	4.60	4.70	4.80
e	2.16	2.28	2.40
e1	4.40		4.60
H	9.35		10.10
L	1.00		1.50
(L1)	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

Figure 20: DPAK (TO-252) recommended footprint (dimensions are in mm)



## 4.2 DPAK (TO-252) packing information

Figure 21: DPAK (TO-252) tape outline

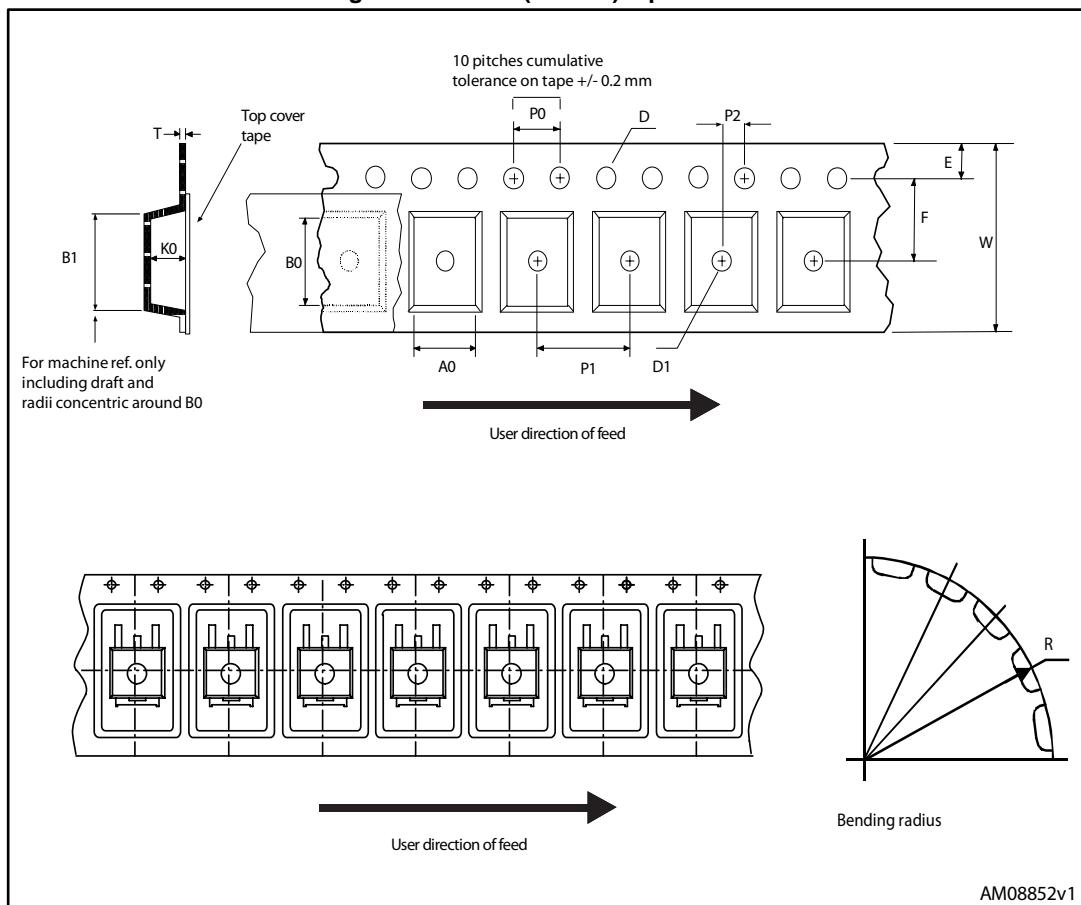


Figure 22: DPAK (TO-252) reel outline

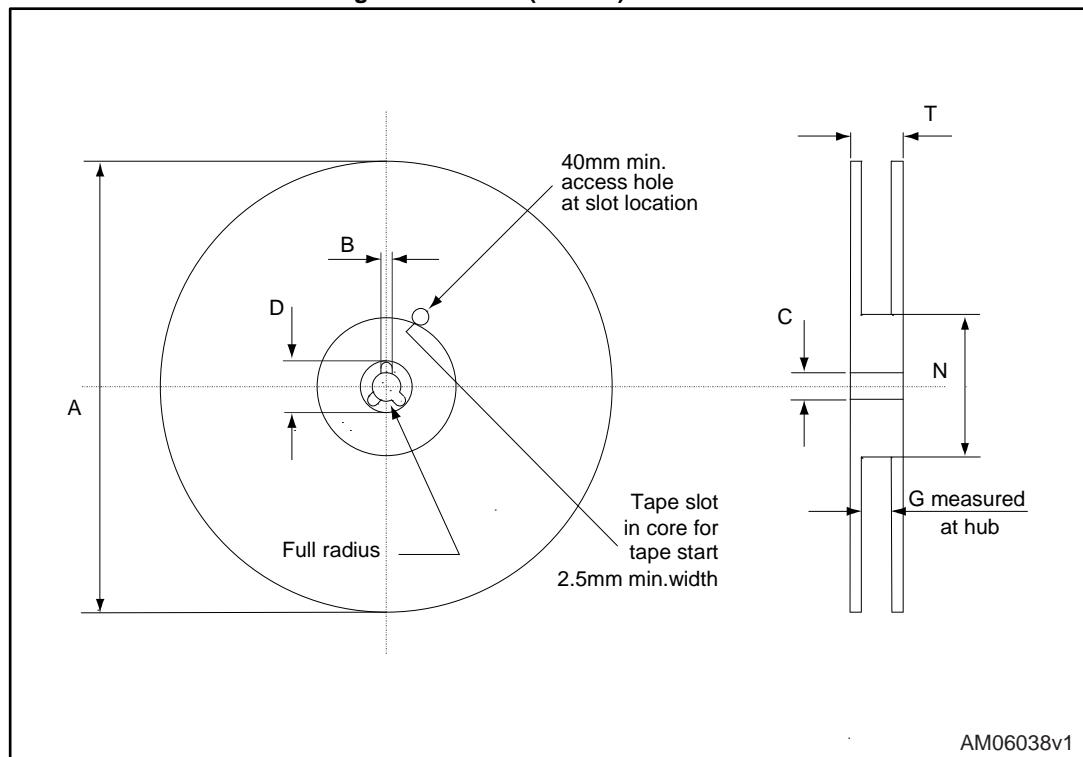


Table 9: DPAK (TO-252) tape and reel mechanical data

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty.		2500
P1	7.9	8.1	Bulk qty.		2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

## 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
30-Jun-2015	1	First release.

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